

APT75GN60B(G) APT75GN60S(G) 600V

Utilizing the latest Field Stop and Trench Gate technologies, these IGBT's have ultra low $V_{CE(ON)}$ and are ideal for low frequency applications that require absolute minimum conduction loss. Easy paralleling is a result of very tight parameter distribution and a slightly positive $V_{CE(ON)}$ temperature coefficient. A built-in gate resistor ensures extremely reliable operation, even in the event of a short circuit fault. Low gate charge simplifies gate drive design and minimizes losses.

- 600V Field Stop
- Trench Gate: Low V_{CE(on)}
- Easy Paralleling
- 6µs Short Circuit Capability
- Intergrated Gate Resistor: Low EMI, High Reliability Applications: Welding, Inductive Heating, Solar Inverters, SMPS, Motor drives, UPS

MAXIMUM RATINGS

All Ratings: $T_c = 25^{\circ}C$ unless otherwise specified.

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Symbol	Parameter	APT75GN60B_S(G)	UNIT	
V _{CES}	Collector-Emitter Voltage	600	Valta	
V _{GE}	Gate-Emitter Voltage	±30	VOILS	
I _{C1}	Continuous Collector Current ⁽⁸⁾ @ $T_c = 25^{\circ}C$	155		
I _{C2}	Continuous Collector Current @ T _C = 110°C	93	Amps	
I _{см}	Pulsed Collector Current ^①	225		
SSOA	Switching Safe Operating Area @ T _J = 175°C	225A @ 600V		
P _D	Total Power Dissipation	536	Watts	
T _J ,T _{STG}	Operating and Storage Junction Temperature Range	-55 to 175	*0	
TL	Max. Lead Temp. for Soldering: 0.063" from Case for 10 Sec.	300		

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	ТҮР	MAX	Units
V _{(BR)CES}	Collector-Emitter Breakdown Voltage (V_{GE} = 0V, I _C = 4mA)	600			- Volts
V _{GE(TH)}	Gate Threshold Voltage $(V_{CE} = V_{GE}, I_{C} = 1mA, T_{j} = 25^{\circ}C)$	5.0	5.8	6.5	
V _{CE(ON)}	Collector-Emitter On Voltage (V_{GE} = 15V, I_C = 75A, T_j = 25°C)	1.05	1.45	1.85	
	Collector-Emitter On Voltage (V_{GE} = 15V, I_C = 75A, T_j = 125°C)		1.87		
I _{CES}	Collector Cut-off Current (V _{CE} = 600V, V _{GE} = 0V, T _j = 25°C) ⁽²⁾			25	μA
	Collector Cut-off Current (V _{CE} = 600V, V _{GE} = 0V, T _j = 125°C) ⁽²⁾				
I _{GES}	Gate-Emitter Leakage Current (V _{GE} = ±20V)			600	nA
R _{G(int)}	Intergrated Gate Resistor		4		Ω

These Devices are Sensitive to Electrostatic Discharge Proper Handling Procedures Should Be Followed.



DYNAMIC CHARACTERISTICS

Symbol	Characteristic	Test Conditions	MIN	ТҮР	MAX	UNIT
C _{ies}	Input Capacitance	Capacitance		4500		
C _{oes}	Output Capacitance	V _{GE} = 0V, V _{CE} = 25V		370		pF
C _{res}	Reverse Transfer Capacitance	f = 1 MHz		150		1
V _{GEP}	Gate-to-Emitter Plateau Voltage	Gate Charge		9.5		V
Q _g	Total Gate Charge ^③	V _{GE} = 15V		485		
Q _{ge}	Gate-Emitter Charge	V _{CE} = 300V		30		nC
Q _{gc}	Gate-Collector ("Miller") Charge	l _c = 75A		270		
SSOA	Switching Safe Operating Area	$T_J = 175^{\circ}C, R_G = 4.3\Omega^{\text{(7)}}, V_{GE} = 15V, L = 100\mu H, V_{CE} = 600V$	225			A
SCSOA	Short Circuit Safe Operating Area	$V_{CC} = 600V, V_{GE} = 15V,$ $T_{J} = 125^{\circ}C, R_{G} = 4.3\Omega^{⑦}$	6			μs
t _{d(on)}	Turn-on Delay Time	Inductive Switching (25°C)		47		
t _r	Current Rise Time	V _{CC} = 400V		48		ne
t _{d(off)}	Turn-off Delay Time	V _{GE} = 15V		385		
t _f	Current Fall Time	I _C = 75A		38		
E _{on1}	Turn-on Switching Energy ④	$R_{G} = 1.0\Omega^{(7)}$		2500		
E _{on2}	Turn-on Switching Energy (Diode) $^{(5)}$	T _J = +25°C		3725		μJ
E _{off}	Turn-off Switching Energy ⁶			2140		
t _{d(on)}	Turn-on Delay Time	Inductive Switching (125°C)		47		
t _r	Current Rise Time	V _{CC} = 400V		48		ne
t _{d(off)}	Turn-off Delay Time	V _{GE} = 15V		430		
t _f	Current Fall Time	I _C = 75A		55		
E _{on1}	Turn-on Switching Energy ^④	R _G = 1.0Ω ^⑦		2600		
E _{on2}	Turn-on Switching Energy (Diode) ^⑤	T _J = +125°C		4525		μJ
E _{off}	Turn-off Switching Energy ⁶	1		2585		1

THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic	MIN	TYP	MAX	UNIT
R _{θJC}	Junction to Case (IGBT)			.28	°C/W
R _{θJC}	Junction to Case (DIODE)			N/A	0,00
W _T	Package Weight		5.9		gm

(1) Repetitive Rating: Pulse width limited by maximum junction temperature.

2 For Combi devices, \textbf{I}_{ces} includes both IGBT and FRED leakages

③ See MIL-STD-750 Method 3471.

(4) E_{on1} is the clamped inductive turn-on energy of the IGBT only, without the effect of a commutating diode reverse recovery current adding to the IGBT turn-on loss. Tested in inductive switching test circuit shown in figure 21, but with a Silicon Carbide diode.

(5) E_{on2} is the clamped inductive turn-on energy that includes a commutating diode reverse recovery current in the IGBT turn-on switching loss. (See Figures 21, 22.)

(6) E_{off} is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1. (See Figures 21, 23.)

 \bigcirc R_G is external gate resistance, not including R_{G(int)} nor gate driver impedance. (MIC4452)

8 Continuous current limited by package pin temperature to 100A.

Microsemi reserves the right to change, without notice, the specifications and information contained herein.













FIGURE 16, Switching Energy Losses vs Junction Temperature









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Figure 21, Inductive Switching Test Circuit



Figure 22, Turn-on Switching Waveforms and Definitions



Figure 23, Turn-off Switching Waveforms and Definitions

TO-247 (B) Package Outline



D³PAK (S) Package Outline



Dimensions in Millimeters (Inches)

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